



Low Loss IGBT: IGBT in TRENCHSTOP™ and Fieldstop technology





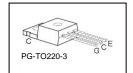




Features:

- Very low V_{CE(sat)} 1.5V (typ.)
- Maximum Junction Temperature 175°C
- Short circuit withstand time 5μs
- Designed for :
 - Frequency Converters
 - Uninterrupted Power Supply
- TRENCHSTOP™ and Fieldstop technology for 600V applications offers :
 - very tight parameter distribution
 - high ruggedness, temperature stable behavior
 - very high switching speed
- Positive temperature coefficient in V_{CE(sat)}
- Low EMI
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹ for target applications
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/





Rev. 2.4 30.04.2015

Туре	V _{CE}	I c	V _{CE(sat),Tj=25°C}	$T_{\rm j,max}$	Marking Code	Package
IGP15N60T	600V	15A	1.5V	175°C	G15T60	PG-TO220-3

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage, <i>T</i> _j ≥ 25°C	V _{CE}	600	V
DC collector current, limited by T_{jmax}			
$T_{\rm C}$ = 25°C, value limited by bondwire	I _C	26	
$T_{\rm C}$ = 100°C		23	Α
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	45	
Turn off safe operating area, $V_{CE} = 600 \text{V}$, $T_j = 175 ^{\circ}\text{C}$, $t_p = 1 \mu\text{s}$	-	45	
Gate-emitter voltage	V_{GE}	±20	V
Short circuit withstand time ²⁾	1	Е	
$V_{\rm GE}$ = 15V, $V_{\rm CC} \le 400$ V, $T_{\rm j} \le 150$ °C	t_{SC}	5	μS
Power dissipation $T_C = 25^{\circ}C$	P _{tot}	130	W
Operating junction temperature	T _j	-40+175	
Storage temperature	$T_{\rm stg}$	-55+150	°C
Soldering temperature wavesoldering, 1.6 mm (0.063 in.) from case for 10s		260	

¹ J-STD-020 and JESD-022

IFAG IPC TD VLS 1

²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.





Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance, junction – case	R _{thJC}		1.15	K/W
Thermal resistance, junction – ambient	R_{thJA}		62	

Electrical Characteristic, at $T_j = 25$ °C, unless otherwise specified

Devemeter	Cumbal	Conditions	Value			Unit
Parameter	Symbol	Conditions	min.	Тур.	max.	Onn
Static Characteristic						
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 0.2 \text{mA}$	600	-	-	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{\rm GE} = 15 \rm V, \ I_{\rm C} = 15 \rm A$				
		<i>T</i> _j =25°C	-	1.5	2.05	
		<i>T</i> _j =175°C	-	1.9	-	
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C} = 210 \mu {\rm A}$, $V_{\rm CE} = V_{\rm GE}$	4.1	4.9	5.7	
Zero gate voltage collector current	I _{CES}	$V_{CE}=600V$, $V_{GE}=0V$				μΑ
		<i>T</i> _j =25°C	-	-	40	
		T _j =175°C	-	-	1000	
Gate-emitter leakage current	I _{GES}	$V_{\text{CE}}=0\text{V}, V_{\text{GE}}=20\text{V}$	-	-	100	nA
Transconductance	g_{fs}	$V_{CE} = 20V, I_{C} = 15A$	-	8.7	-	S
Integrated gate resistor	R _{Gint}			-		Ω

Dynamic Characteristic

Input capacitance	Ciss	$V_{CE}=25V$,	-	860	-	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	55	-	
Reverse transfer capacitance	C _{rss}	f=1MHz	-	24	-	
Gate charge	Q _{Gate}	$V_{\rm CC} = 480 \text{V}, I_{\rm C} = 15 \text{A}$	-	87	-	nC
		V _{GE} =15V				
Internal emitter inductance	LE		-	7	-	nΗ
measured 5mm (0.197 in.) from case						
Short circuit collector current ¹⁾	$I_{C(SC)}$	$V_{\text{GE}} = 15 \text{V}, t_{\text{SC}} \le 5 \mu \text{S}$ $V_{\text{CC}} = 400 \text{V},$ $T_{\text{j}} = 150 ^{\circ} \text{C}$	-	137.5	-	A

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



IGP15N60T

TRENCHSTOP™ Series

Switching Characteristic, Inductive Load, at T_j =25 °C

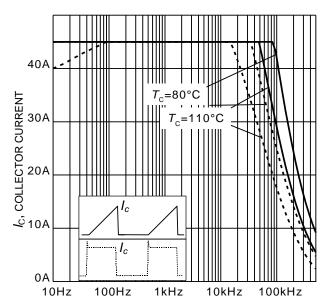
Davamatar	Symbol	Conditions	Value			Unit
Parameter			min.	Тур.	max.	Unit
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =25°C,	-	17	-	ns
Rise time	t_{r}	$V_{\rm CC} = 400 \text{V}, I_{\rm C} = 15 \text{A},$ $V_{\rm GE} = 0/15 \text{V}, I_{\rm C} = 15 \Omega,$	-	11	-	
Turn-off delay time	$t_{d(off)}$	L_{σ} =154nH, C_{σ} =39pF L_{σ} , C_{σ} from Fig. E Energy losses include "tail" and diode reverse	-	188	-	
Fall time	t_{f}		-	50	-	
Turn-on energy	Eon		-	0.22	-	mJ
Turn-off energy	E _{off}		-	0.35	-	
Total switching energy	E _{ts}	recovery.	-	0.57	-	

Switching Characteristic, Inductive Load, at T_j =175 °C

Parameter	Symbol	Conditions	Value			Unit
Parameter			min.	Тур.	max.	Unit
IGBT Characteristic	·					
Turn-on delay time	$t_{d(on)}$	$T_j=175^{\circ}\text{C},$	-	17	-	ns
Rise time	t _r	$V_{CC} = 400 \text{ V}, I_{C} = 15 \text{ A},$ $V_{GE} = 0/15 \text{ V}, r_{G} = 15 \Omega,$	-	15	-	1
Turn-off delay time	t _{d(off)}	L_{σ} =154nH, C_{σ} =39pF	-	212	-	
Fall time	t_{f}		-	79	-	
Turn-on energy	Eon	L_{σ} , C_{σ} from Fig. E Energy losses include "tail" and diode reverse recovery.	-	0.34	-	mJ
Turn-off energy	E _{off}		-	0.47	-	
Total switching energy	E _{ts}		-	0.81	-	

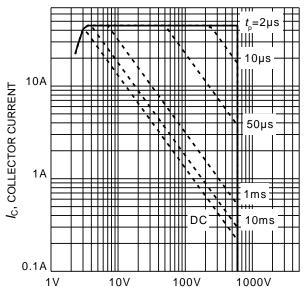






f, SWITCHING FREQUENCY

Figure 1. Collector current as a function of switching frequency $(T_j \le 175^{\circ}\text{C}, D = 0.5, V_{\text{CE}} = 400\text{V}, V_{\text{GE}} = 0/15\text{V}, r_{\text{G}} = 15\Omega)$



 $V_{\sf CE}$, COLLECTOR-EMITTER VOLTAGE

Figure 2. Safe operating area $(D=0, T_C=25^{\circ}\text{C}, T_j \leq 175^{\circ}\text{C}; V_{GE}=0/15\text{V})$

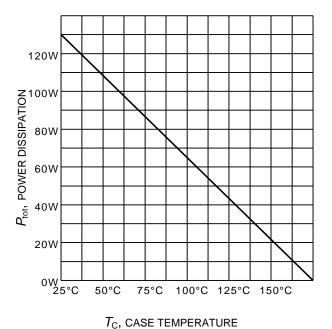
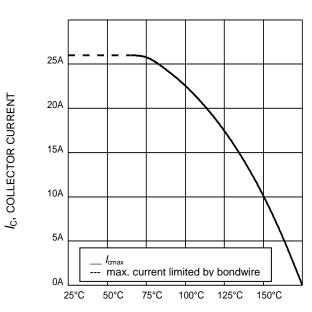


Figure 3. Power dissipation as a function of case temperature $(T_i \le 175^{\circ}\text{C})$



 $T_{\rm C}$, CASE TEMPERATURE

Figure 4. Collector current as a function of case temperature $(V_{GE} \ge 15V, T_j \le 175^{\circ}C)$





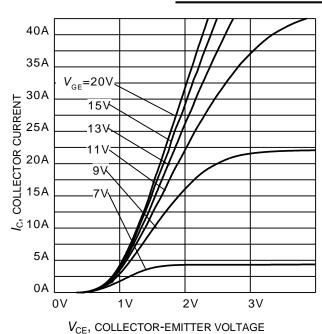


Figure 5. Typical output characteristic $(T_i = 25^{\circ}C)$

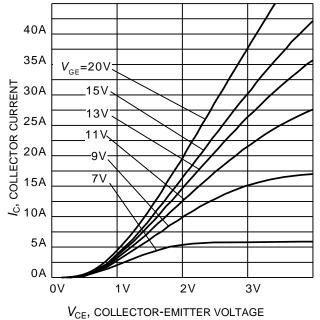
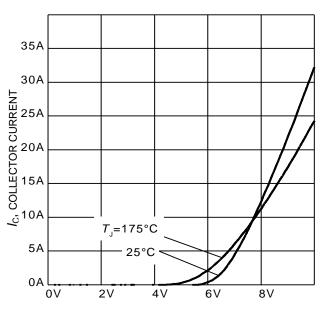
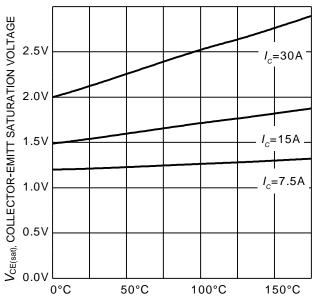


Figure 6. Typical output characteristic $(T_i = 175^{\circ}C)$



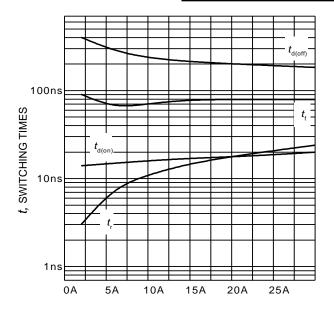
 $V_{\text{GE}}, \, \text{GATE-EMITTER VOLTAGE} \\ \textbf{Figure 7.} \quad \textbf{Typical transfer characteristic} \\ (V_{\text{CE}} = 20 \text{V}) \\ \end{cases}$



 $T_{\rm J}$, JUNCTION TEMPERATURE Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature ($V_{\rm GE}=15\rm V$)







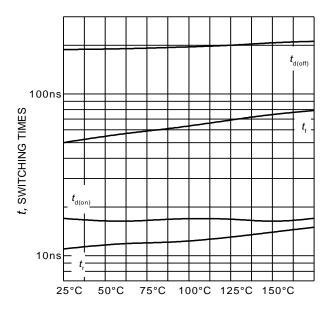
SOUTH ONLY TO THE PROPERTY OF THE PROPERTY OF

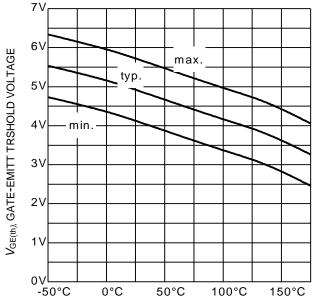
 $I_{\rm C}$, COLLECTOR CURRENT

Figure 9. Typical switching times as a function of collector current (inductive load, T_J =175°C, V_{CE} = 400V, V_{GE} = 0/15V, r_G = 15 Ω , Dynamic test circuit in Figure E)

 $R_{\rm G}$, gate resistor

Figure 10. Typical switching times as a function of gate resistor (inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $I_C = 15$ A, Dynamic test circuit in Figure E)





 $T_{
m J}$, JUNCTION TEMPERATURE

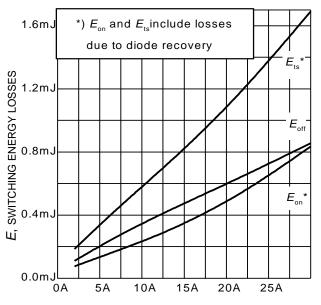
Figure 11. Typical switching times as a function of junction temperature (inductive load, $V_{\rm CE}$ = 400V, $V_{\rm GE}$ = 0/15V, $I_{\rm C}$ = 15A, $r_{\rm G}$ =15 Ω , Dynamic test circuit in Figure E)

 $T_{\rm J}$, JUNCTION TEMPERATURE

Figure 12. Gate-emitter threshold voltage as a function of junction temperature $(I_C = 0.21 \text{mA})$







 I_{C} , COLLECTOR CURRENT

Figure 13. Typical switching energy losses as a function of collector current (inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $r_G = 15\Omega$, Dynamic test circuit in Figure E)

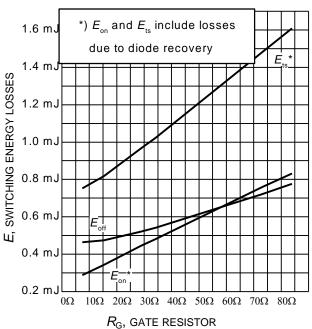


Figure 14. Typical switching energy losses

as a function of gate resistor (inductive load, $T_J = 175$ °C, $V_{CE} = 400$ V, $V_{GE} = 0/15$ V, $I_C = 15$ A, Dynamic test circuit in Figure E)

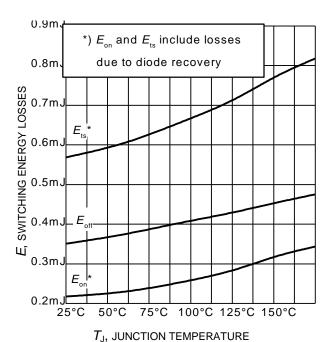
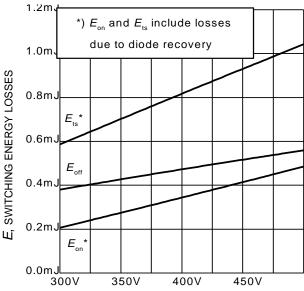


Figure 15. Typical switching energy losses as a function of junction temperature

(inductive load, $V_{\rm CE}$ = 400V, $V_{\rm GE}$ = 0/15V, $I_{\rm C}$ = 15A, $r_{\rm G}$ = 15 Ω , Dynamic test circuit in Figure E)



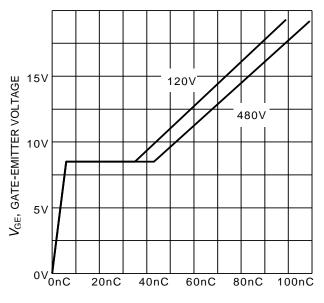
 V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 16. Typical switching energy losses as a function of collector emitter voltage

(inductive load, T_J = 175°C, V_{GE} = 0/15V, I_C = 15A, r_G = 15 Ω , Dynamic test circuit in Figure E)

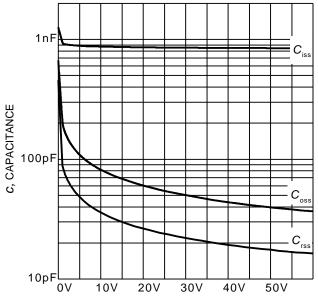






Q_{GE}, GATE CHARGE

Figure 17. Typical gate charge $(I_C=15 \text{ A})$



 V_{CE} , COLLECTOR-EMITTER VOLTAGE

Figure 18. Typical capacitance as a function of collector-emitter voltage $(V_{GE}=0V, f=1 \text{ MHz})$

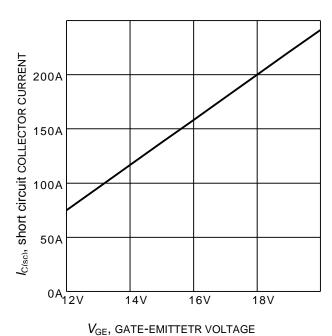
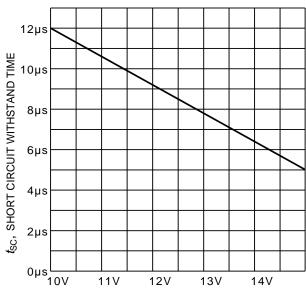


Figure 19. Typical short circuit collector current as a function of gate-

emitter voltage

($V_{CE} \le 400 \text{V}$, $T_j \le 150 ^{\circ}\text{C}$)



 $V_{\rm GE}$, gate-emitetr voltage

Figure 20. Short circuit withstand time as a function of gate-emitter voltage (V_{CE} =400V, start at T_{J} =25°C, T_{Jmax} <150°C)





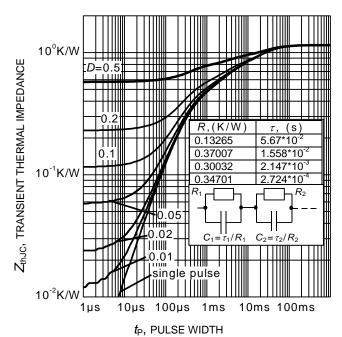
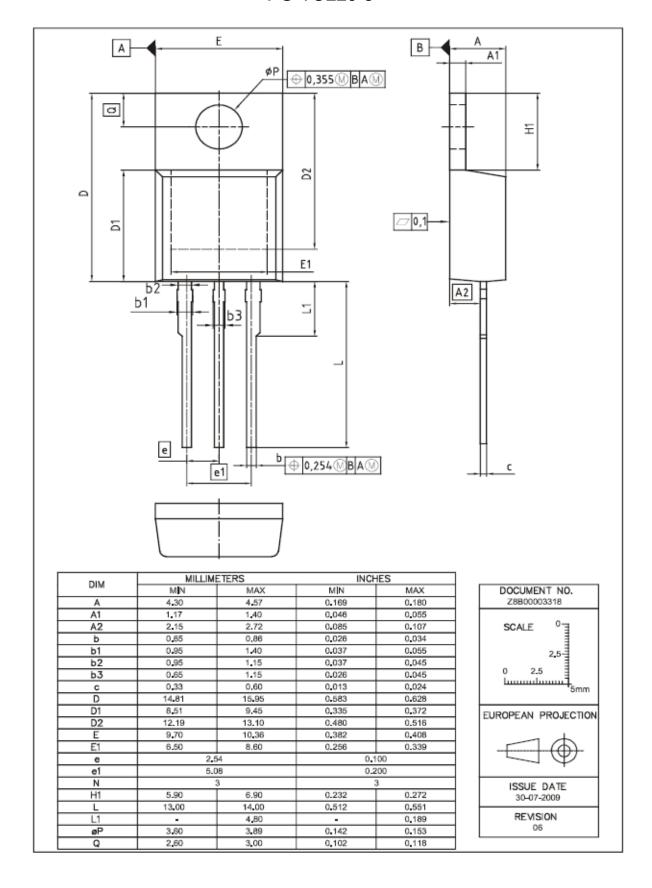


Figure 21. IGBT transient thermal impedance $(D = t_p / T)$

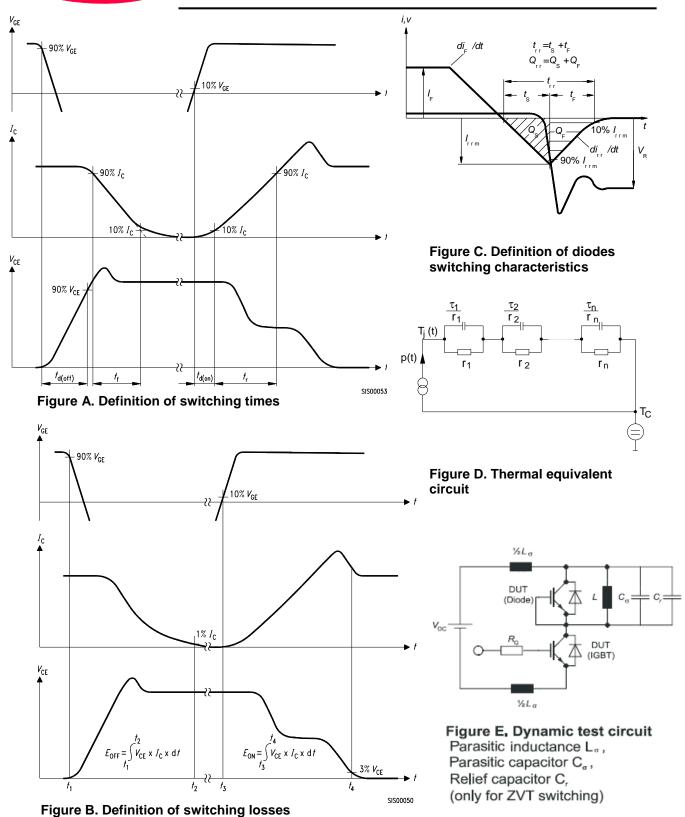


PG-TO220-3











IGP15N60T

TRENCHSTOP™ Series

Published by Infineon Technologies AG 81726 Munich, Germany © 2015 Infineon Technologies AG All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for IGBT Transistors category:

Click to view products by Infineon manufacturer:

Other Similar products are found below:

 748152A
 FGH60T65SHD_F155
 APT100GT60B2RG
 APT13GP120BG
 APT15GN120BDQ1G
 APT20GN60BG
 APT20GT60BRDQ1G

 APT25GN120B2DQ2G
 APT35GA90BD15
 APT36GA60BD15
 APT40GP60B2DQ2G
 APT40GP90B2DQ2G
 APT50GN120B2G

 APT50GT60BRG
 APT64GA90B2D30
 APT70GR120J
 NGTB10N60FG
 NGTB30N60L2WG
 NGTG25N120FL2WG
 IGP30N60H3XKSA1

 IGW40N60H3FKSA1
 STGB15H60DF
 STGFW20V60DF
 STGFW30V60DF
 STGFW40V60F
 STGWA25H120DF2
 FGB3236_F085

 APT13GP120BDQ1G
 APT25GN120BG
 APT25GR120S
 APT30GN60BDQ2G
 APT30GN60BG
 APT30GF60BG
 APT30GS60BRDQ2G

 APT30N60BC6
 APT35GP120JDQ2
 APT36GA60B
 APT45GR65B2DU30
 APT50GP60B2DQ2G
 APT68GA60B
 APT70GR65B

 APT70GR65B2SCD30
 GT50JR22(STA1ES)
 TIG058E8-TL-H
 IDW40E65D2
 NGTB50N60L2WG
 STGB10H60DF
 STGB20V60F

 STGB40V60F
 STGFW80V60F
 STGFW80V60F
 STGB20V60F
 STGB20V60F